



FQT1N80TF_WS N-Channel MOSFET 800V, 0.2A, 20 Ω

Features

- $R_{DS(on)} = 15.5\Omega$ (Typ.)@ $V_{GS} = 10V$, $I_D = 0.1A$
- Low gate charge (Typ. 5.5nC)
- Low Crss (Typ. 2.7pF)
- · Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- · RoHS compliant

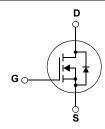


Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

Symbol	Parameter			FQT1N80TF_WS	Units	
V _{DSS}	Drain to Source Voltage			800	V	
V _{GSS}	Gate to Source Voltage			±30	V	
ı	Drain Current	-Continuous (T _C = 25°C)		0.2	^	
ID	DialifCurrent	-Continuous (T _C = 100°C)		0.12	A	
I _{DM}	Drain Current	- Pulsed	(Note 1)	0.8	Α	
E _{AS}	Single Pulsed Avalanche Energ	gy	(Note 2)	90	mJ	
I _{AR}	Avalanche Current (Not		(Note 1)	0.2	Α	
E _{AR}	Repetitive Avalanche Energy		(Note 1)	0.2	mJ	
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.0	V/ns	
D	Dower Discipation	(T _C = 25°C)		2.1	W	
P_D	Power Dissipation	- Derate above 25°C		0.02	W/°C	
T _J , T _{STG}	Operating and Storage Temper	rature Range		-55 to +150	°C	
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	°C		

Thermal Characteristics

Symbol	Parameter		Max.	Units
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient*	-	60	°C/W

 $^{^{\}star}$ When mounted on the minimum pad size recommended (PCB Mount)

Package Marking and Ordering Information T_C = 25°C unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FQT1N80	FQT1N80TF_WS	SOT-223	330mm	12mm	4000

Electrical Characteristics

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V, T_J = 25^{\circ} C$	800	-	-	V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25 $^{\circ}$ C	-	0.8	-	V/°C
1	Zero Gate Voltage Drain Current	V _{DS} = 800V, V _{GS} = 0V	-	-	25	
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 640V, T_{C} = 125^{\circ}C$	-	-	250	μА
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	3.0	-	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10V, I _D = 0.1A	-	15.5	20	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40V, I _D = 0.1A (Note 4)	-	0.75	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	\\ - 25\\ \\ - 0\\	-	150	195	pF
C _{oss}	Output Capacitance	V _{DS} = 25V, V _{GS} = 0V f = 1MHz	-	20	30	pF
C _{rss}	Reverse Transfer Capacitance	111112	-	2.7	5.0	pF
Q_g	Total Gate Charge at 10V		-	5.5	7.2	nC
Q _{gs}	Gate to Source Gate Charge	$V_{DS} = 640V, I_{D} = 1A$	-	1.1	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{GS} = 10V (Note 4, 5)	-	3.3	-	nC

Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time		-	10	30	ns
t _r	Turn-On Rise Time	$V_{DD} = 400V, I_{D} = 1A$	-	25	60	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25\Omega$	-	15	40	ns
t _f	Turn-Off Fall Time	(Note 4, 5)	-	25	60	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current			-	-	0.2	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	-	0.8	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _{SD} = 0.2A		-	-	1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 1A		-	300	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	(Note 4)	-	0.6	-	μС

Notes

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 170mH, I_{AS} = 1A, V_{DD} = 50V, R_{G} = 25 $\!\Omega$, Starting T_{J} = 25 $^{\circ}C$
- 3. I $_{SD} \leq$ 1A, di/dt \leq 200A/ μ s, V $_{DD} \leq$ BV $_{DSS}$, Starting T $_{J}$ = 25°C
- 4. Pulse Test: Pulse width $\leq 300 \mu s,$ Duty Cycle $\leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

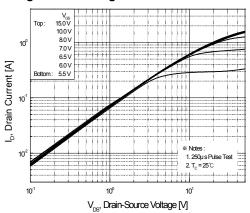


Figure 2. Transfer Characteristics

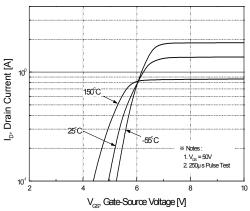


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

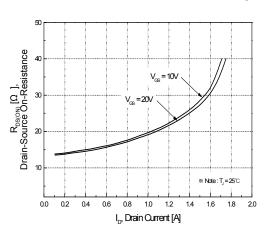


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

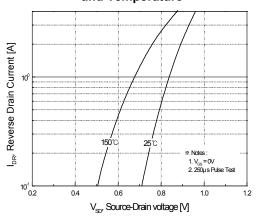


Figure 5. Capacitance Characteristics

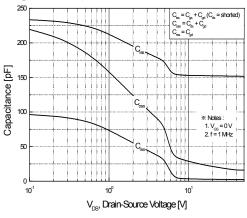
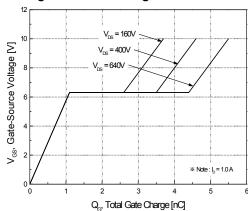


Figure 6. Gate Charge Characteristics



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Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

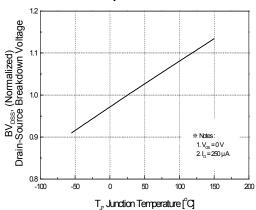


Figure 8. On-Resistance Variation vs. Temperature

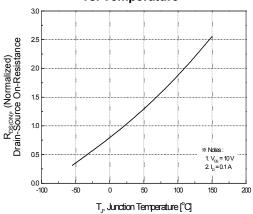


Figure 9. Maximum Safe Operating Area

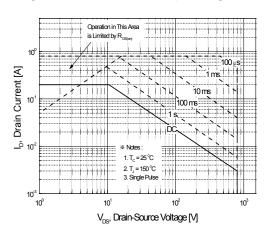


Figure 10. Maximum Drain Current vs. Case Temperature

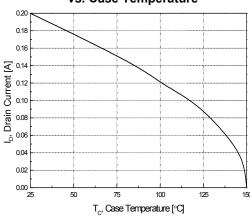
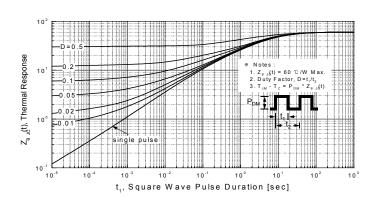
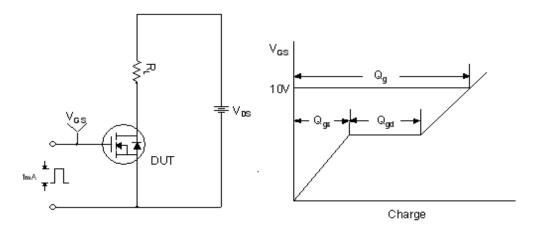


Figure 11. Transient Thermal Response Curve

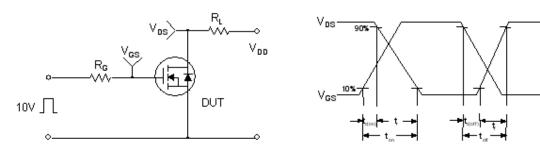


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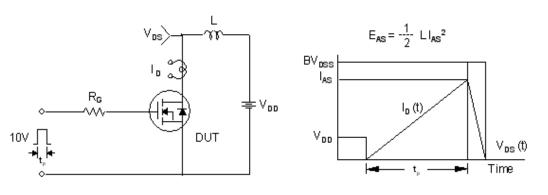
Gate Charge Test Circuit & Waveform

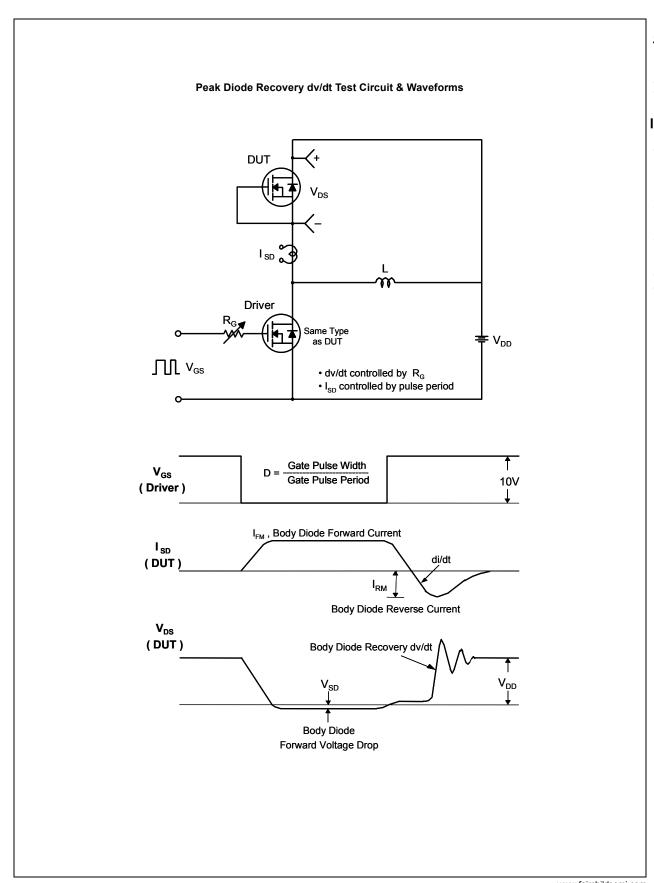


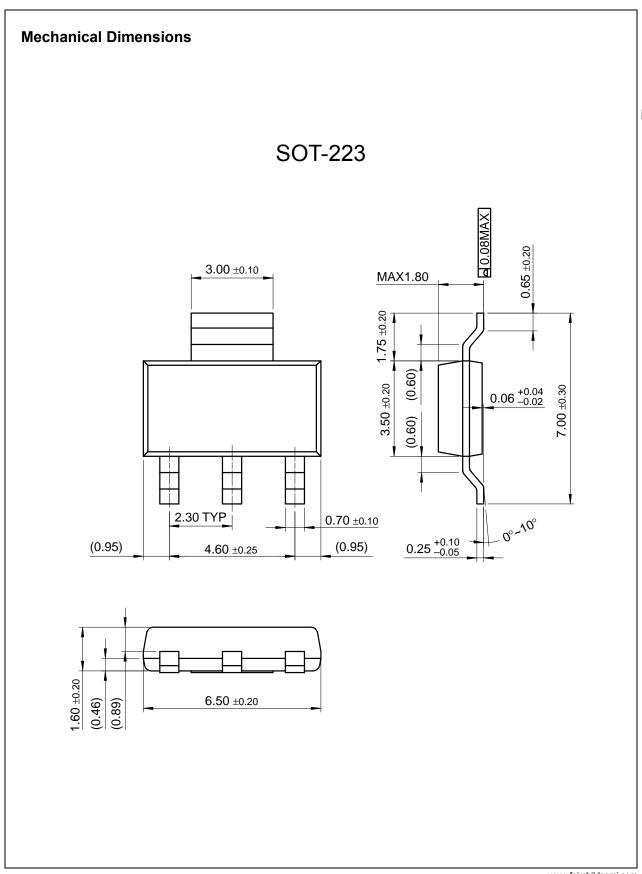
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms











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